Overview of the automatic reconstruction method for quantitative phase imaging using a digital holographic microscope operating in non-telecentric regime

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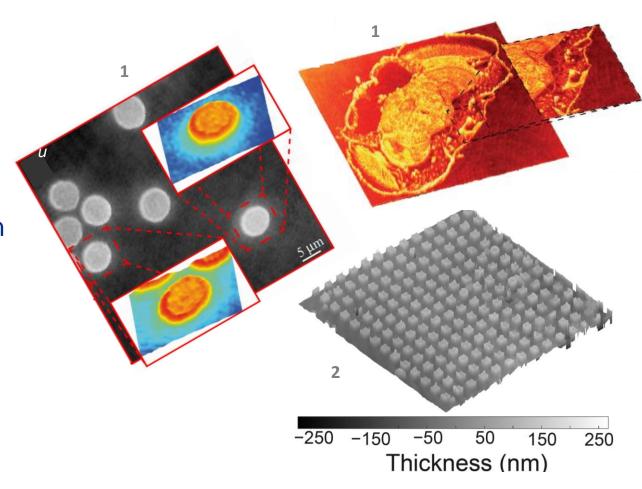




Digital Holographic Microscopy (DHM)

Highlights:

- ☐ Quantitative Phase Imaging (QPI) modality largely used for material and biological applications.
- ☐ Provides label-free (i.e., unstained) imaging.
- ☐ Reconstructed amplitude and phase information of the sample.
- Off-axis DHM systems allow for single-shot imaging.







A digital hologram is a *hybrid* imaging method:

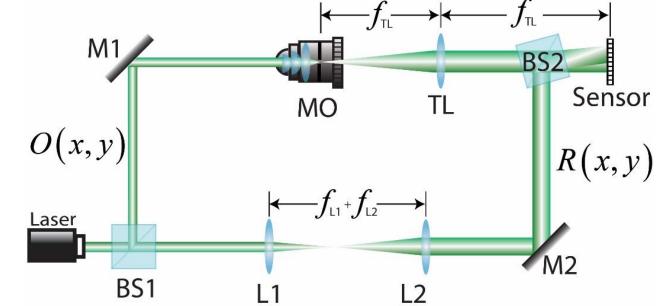
Optical recording stage: interference between two beams

Reference beam (i.e., plane wave):

$$r(x) = \exp(ik \cdot x)$$

 $x = (x, y); k = (k_x, k_y)$
Reference angle

Object beam:
$$u_{IP}(x) \propto \frac{1}{M_L^2} o\left(\frac{x}{M_L}\right) \otimes_2 P\left(\frac{x}{\lambda f_{TL}}\right)$$





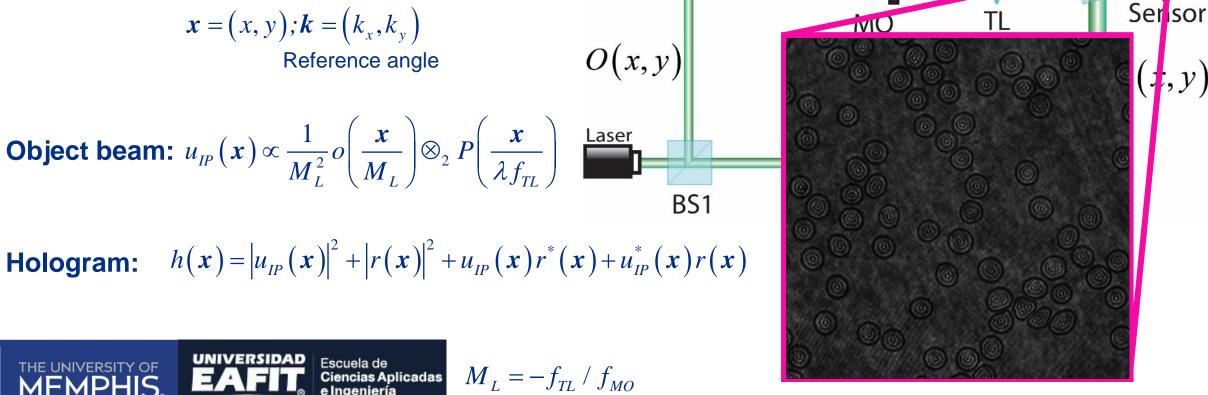
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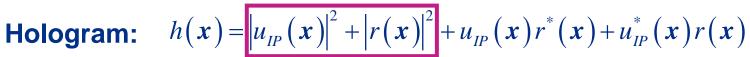
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 Laser

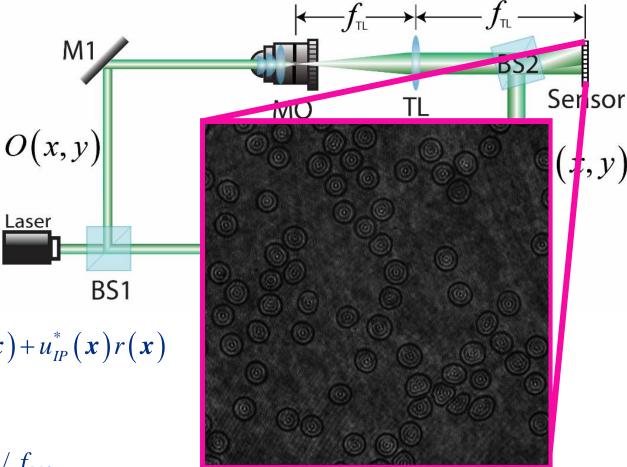


Intensity information









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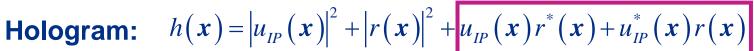
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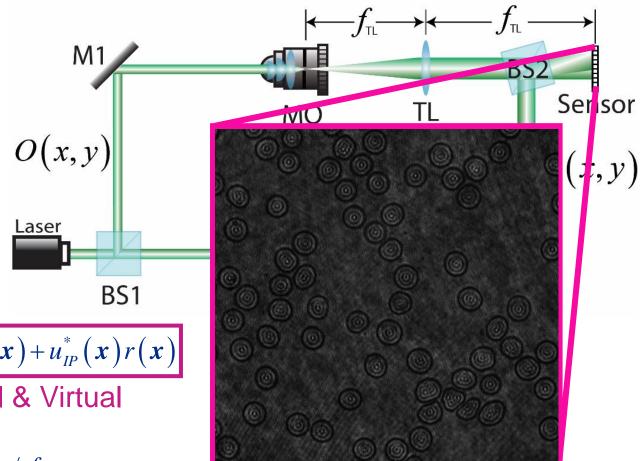


Real & Virtual





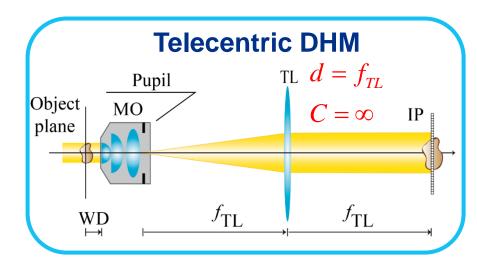




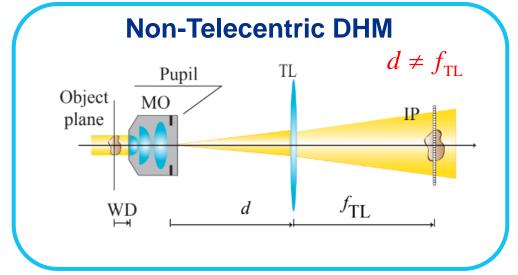
Optical configuration of the DHM system: telecentric versus non-telecentric

Complex amplitude distribution at the image plane (IP)

$$C = \frac{f_{\rm TL}^2}{f_{\rm TL} - d}$$



$$u_{IP}(\mathbf{x}) \propto \frac{1}{M_L^2} \left\{ o\left(\frac{\mathbf{x}}{M_L}\right) \otimes_2 P\left(\frac{\mathbf{x}}{\lambda f_{TL}}\right) \right\}$$



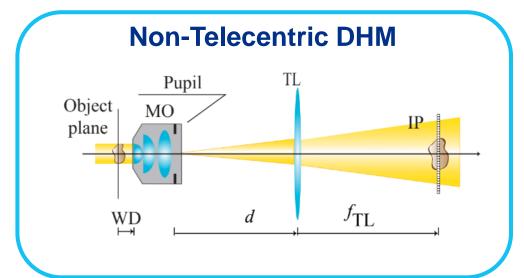
$$u_{IP}(\mathbf{x}) \propto \frac{1}{M_L^2} \exp\left(i\frac{\mathbf{x}}{2\mathbf{C}}|\mathbf{x}|^2\right) \times \left\{o\left(\frac{\mathbf{x}}{M_L}\right) \otimes_2 P\left(\frac{\mathbf{x}}{\lambda f_{TL}}\right)\right\}$$

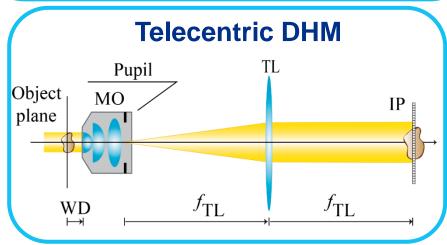
$$M_L = -f_{TL} / f_{MO}$$

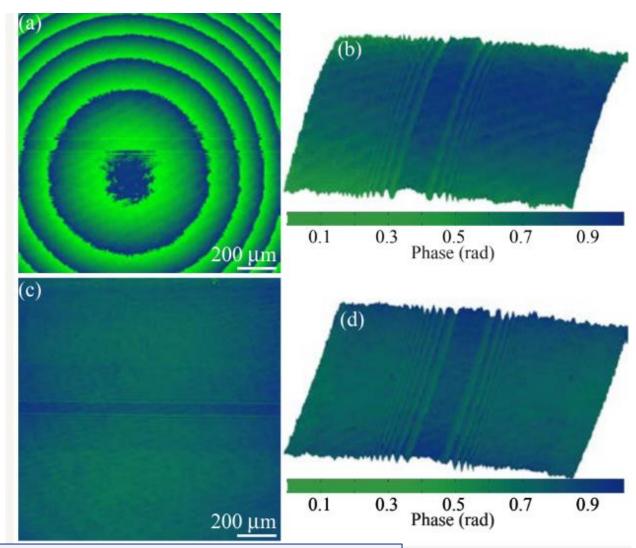




Optical configuration of the DHM system: telecentric versus non-telecentric







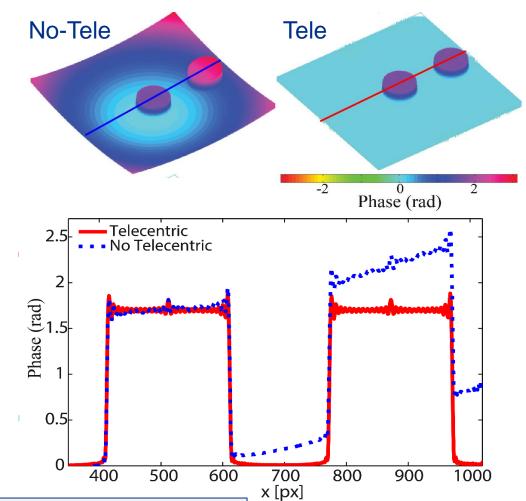




Doblas *et al.*, *Opt. Letters* 38, 1352 (2013). **Doblas** *et al.*, *J. Biomed. Opt.* 19, 046022 (2014).

The performance of DHM technologies relies heavily on computational reconstruction methods to provide accurate phase measurements

- ☐ The optical configuration of the imaging systems creates shift-invariant vs shift-variant measurements.
- □ Telecentric-based DHM systems provide accurate phase values over the whole field of view.
- Non-telecentric DHM systems should compensate for the spherical wavefront associated with a non-telecentric configuration



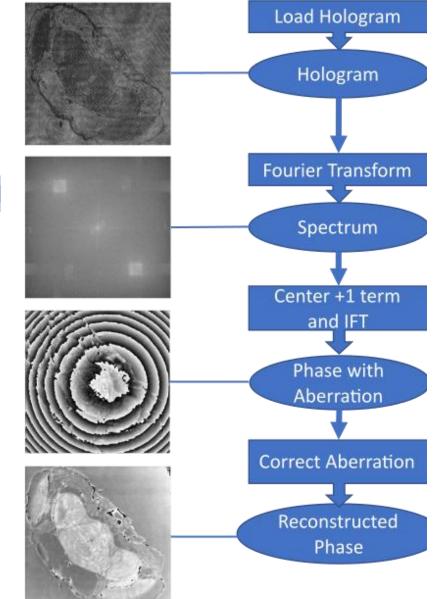




Requirement of the linear and quadratic compensation for QPI measurements in non-telecentric DHM systems

To reconstruct the phase map from a hologram, one should isolate the +1 term and correct for the distortions:

$$h_F(\mathbf{x}) = r^*(\mathbf{x})u_{IP}(\mathbf{x}) = a_o\left(\frac{\mathbf{x}}{M_L}\right) \exp\left[i\varphi_o\left(\frac{\mathbf{x}}{M_L}\right)\right] \exp\left[it(\mathbf{x})\right] \exp\left[is(\mathbf{x})\right]$$







Requirement of the linear and quadratic compensation for QPI measurements in non-

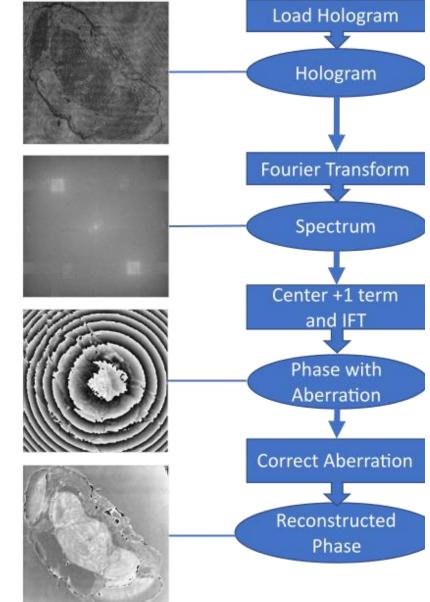
telecentric DHM systems

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Distortions:

1. Tilt aberrations - $t(x) = \frac{2\pi}{\lambda} (x \sin \theta_x + y \sin \theta_y)$







Requirement of the linear and quadratic compensation for QPI measurements in non-

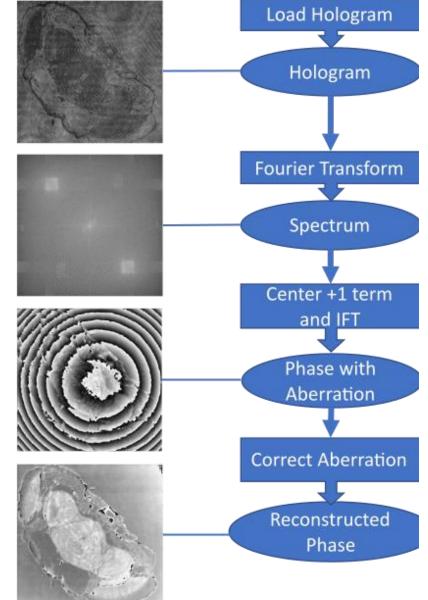
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Distortions:

- 1. Tilt aberrations $t(x) = \frac{2\pi}{\lambda} (x \sin \theta_x + y \sin \theta_y)$
- 2. Spherical aberrations $s(x) = \frac{k}{C} \left[(x x_C)^2 + (y y_C)^2 \right]$







$$k = \frac{2\pi}{\lambda}$$

Requirement of the linear and quadratic compensation for QPI measurements in non-

telecentric DHM systems

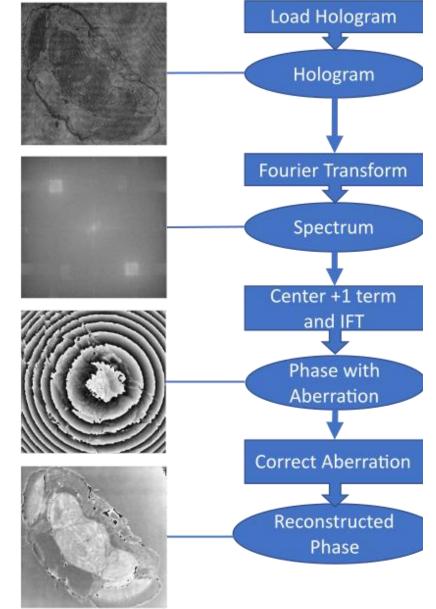
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Corrected Phase Map:
$$\hat{\varphi}_o(x) = \text{angle}[h_F(x)] - t(x) - s(x)$$

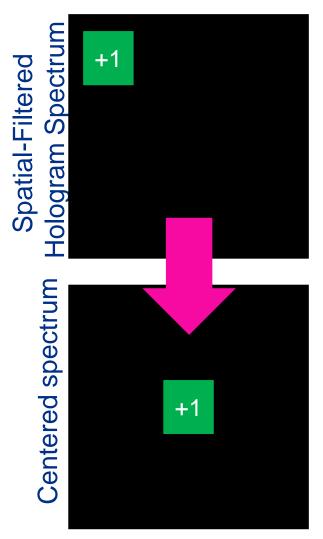






$$k = \frac{2\pi}{\lambda}$$

Requirement of the generation of a digital reference beam for QPI measurements



- 1. Inverse FT of the filtered hologram spectrum $h_F(x)$
- 2. Generation of a digital reference wave

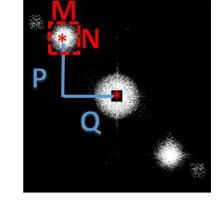
$$r_{D}(m,n) = \sum_{m,n} \exp\left[i\frac{2\pi}{\lambda} \left(m \operatorname{Esin}(\theta_{x}) X + n \operatorname{Esin}(\theta_{y}) Y\right) \Delta_{xy}\right]$$

Reference angle, $\theta = (\theta_x, \theta_y)$, is provided by the center pixel position of

the order +1, (P, Q)

$$\theta_{x} = \sin^{-1} \left(\frac{|u_{0} - P| \lambda}{X \Delta_{xy}} \right)$$

$$\theta_{y} = \sin^{-1} \left(\frac{|v_{0} - Q| \lambda}{Y \Delta_{xy}} \right)$$



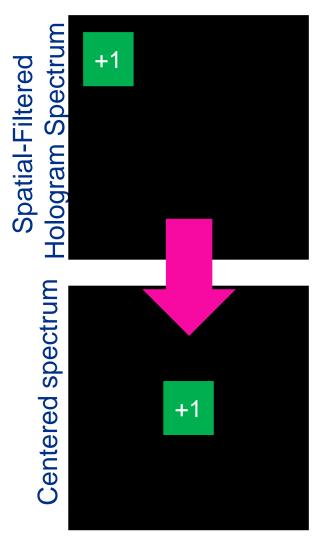




 $(X, Y) \rightarrow$ size of the reconstructed image $(m,n) \rightarrow$ index pixel position $\lambda \rightarrow$ source's wavelength

 $\Delta_{xy} \rightarrow \text{square pixel size}$ $(u_0, v_0) = (X/2+1, Y/2+1)$

Requirement of the generation of a digital reference beam for QPI measurements



- 1. Inverse FT of the filtered hologram spectrum $h_F(x)$
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$$r_{D}(m,n) = \sum_{m,n} \exp\left[i\frac{2\pi}{\lambda} \left(m \sin \theta_{x} \Box X + n \sin \theta_{y} \Box Y\right) \Delta_{xy}\right]$$

3. Complex object information without distortion of the reference beam

$$\hat{o}(\mathbf{x}) = r_D(\mathbf{x}) \square h_F(\mathbf{x})$$

4. Estimation of the phase map

$$\hat{\varphi}(x) = \tan^{-1} \left(\frac{\operatorname{Im} \left[\hat{o}(x) \right]}{\operatorname{Re} \left[\hat{o}(x) \right]} \right)$$





Need for correct estimation of the center position of the +1 term

The angle of the reference wave is determined by the source's wavelength (λ), the features of the digital sensor (X, Y, Δ_{xy}) and the subtraction between the pixel positions of the DC and +1 terms

$$\theta_{x} = \sin^{-1} \left(\frac{|u_{0} + P| \lambda}{X \Delta_{xy}} \right) \qquad \theta_{y} = \sin^{-1} \left(\frac{|v_{0} + Q| \lambda}{Y \Delta_{xy}} \right)$$

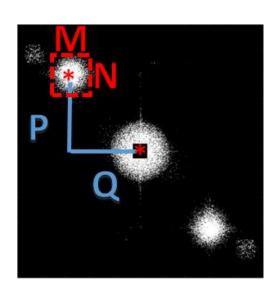




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PROPOSED STEP TO IDENTIFY AND SELECT +1 TERM

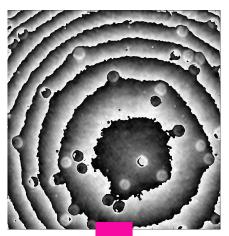
- ☐ Use of Otsu's method for global thresholding to identify the different terms in the hologram's spectrum.
- ☐ The DC term must be blocked before applying the Otsu's method.
- □ Apply image segmentation technique to the binarized hologram's spectrum to identify the ±1 terms.





Requirement of the generation of a digital reference beam for QPI measurements

Phase image after Compensating the linear tilt



Compensated
Phase Image

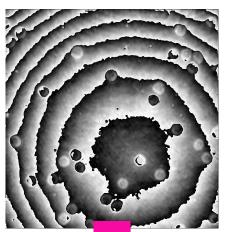
- 1. Phase Image after compensating the linear tilt
 - $\hat{\varphi}'_{o}(\mathbf{x}) = \text{angle}[h_{F}(\mathbf{x})] t(\mathbf{x})$
- 2. Generation of a quadratic phase factor

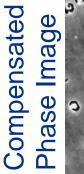
$$s(\mathbf{x}) = \frac{k}{C} \left[\left(x - x_C \right)^2 + \left(y - y_C \right)^2 \right]$$

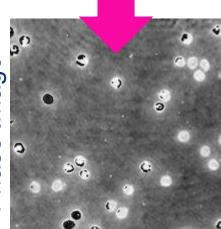


Requirement of compensating the quadratic phase factor for QPI measurements

Sompensating







1. Phase Image after compensating the linear tilt

$$\hat{\varphi}'_{o}(\mathbf{x}) = \text{angle} \left[h_{F}(\mathbf{x}) \right] - t(\mathbf{x})$$

2. Generation of a quadratic phase factor

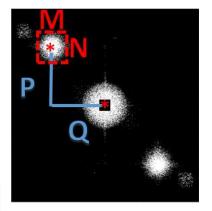
$$s(x) = \frac{k}{C} \left[\left(x - x_C \right)^2 + \left(y - y_C \right)^2 \right]$$

 $s(x) = \frac{k}{C} \left[(x - x_C)^2 + (y - y_C)^2 \right]$ Curvature, $C = (C_x, C_y)$, is provided by the size of the order +1, (M, N)

$$C_{x} = \frac{\left(X\Delta_{xy}\right)^{2}}{\lambda M}$$

$$C_{y} = \frac{\left(Y\Delta_{xy}\right)^{2}}{\lambda N}$$

Sanchez-Ortiga, Doblas et al., Appl. Opt. 53, 2058 (2014).





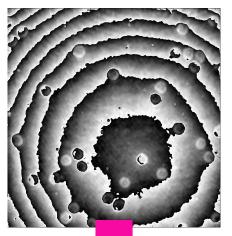


 $(X,Y) \rightarrow$ size of the reconstructed image $(m,n) \rightarrow \text{index pixel position}$ $\lambda \rightarrow$ source's wavelength

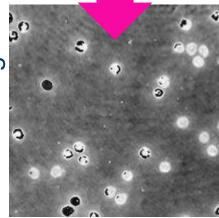
 $\Delta_{xv} \rightarrow$ square pixel size

Requirement of compensating the quadratic phase factor for QPI measurements

hase image after Compensating the linear tilt





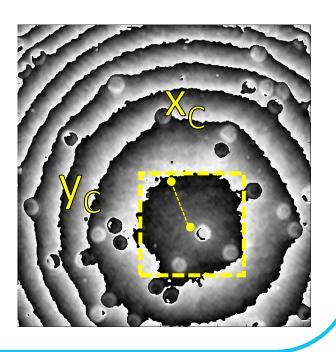


- 1. Phase Image after compensating the linear tilt
- 2. Generation of a quadratic phase factor

$$s(x) = \frac{k}{C} \left[\left(x - \left(x_C \right)^2 + \left(y - \left(y_C \right)^2 \right) \right]$$

The center of the quadratic phase factor, (x_C, y_C) , can be measured from the phase image.

$$\hat{\varphi}'_{o}(\mathbf{x}) = \text{angle}[h_{F}(\mathbf{x})] - t(\mathbf{x})$$



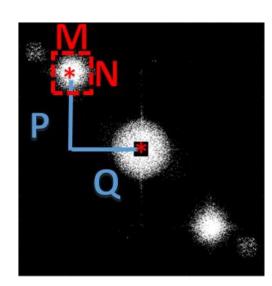


Need for correct estimation of the quadratic phase factor

The curvature of the quadratic phase factor is determined by the source's wavelength (λ), the features of the digital sensor (X, Y, Δ_{xv}) and the size of the +1 term

$$C_{x} = \frac{\left(X\Delta_{xy}\right)^{2}}{\lambda M}$$

$$C_{y} = \frac{\left(Y\Delta_{xy}\right)^{2}}{\lambda(N)}$$



PROPOSED STEP TO IDENTIFY AND SELECT +1 TERM

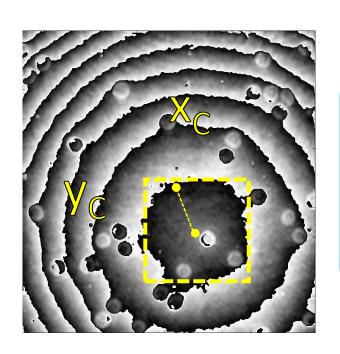
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- ☐ The DC term must be blocked before applying the Otsu's method.
- □ Apply image segmentation technique to the binarized hologram's spectrum to identify the ±1 terms.



Need for correct estimation of the quadratic phase factor

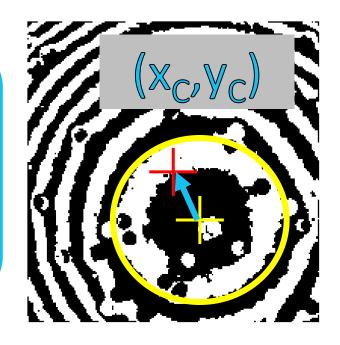
The center of the quadratic phase factor is determined from the phase image after compensating the linear tilt

$$s(x) = \frac{k}{C} \left[\left(x - \left(x_C \right)^2 + \left(y - \left(y_C \right)^2 \right) \right]$$



PROPOSED STEP TO IDENTIFY CENTER OF QUADRATIC TERM

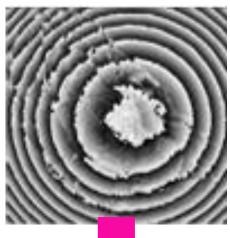
- ☐ Use of Otsu's method for binarizing the phase image.
- ☐ Select one of the concentric rings.
- Measure distance of the concentric ring to the center of the image



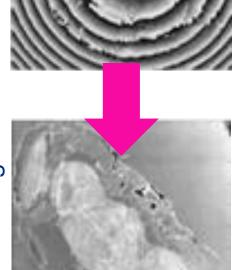


Need for a fine-tuning compensation through a minimization

Compensated Phase image







- 1. Phase Image after compensating the linear tilt and the quadratic phase factor $\hat{\varphi}_o(x) = \text{angle}[h_F(x)] t(x) s(x)$
- 2. Generation of a **residual** quadratic phase factor

$$s_R(\mathbf{x}) = \frac{k}{C_R} \left[x^2 + y^2 \right]$$

The residual curvature, C_R , estimated by minimizing the standard deviation of the reconstructed phase image (e.g., minimizing the number of phase wraps in the image). We found that the best optimizer was the a hybrid between genetic algorithm and patterns search (ga+ps).



Summary

- ☑ We outline the implementation steps necessary for automatic reconstruction method for quantitative phase imaging using a digital holographic microscope operating in non-telecentric regime.
- ☑ Our implementation only requires that the user knows the wavelength of the laser used and the camera specifications (i.e., pixel and sensor size).
- □ Comparison of alternative thresholding image segmentation methods and cost functions
- ☐ Investigation of alternative approaches to reduce reconstruction times
- Single reconstruction algorithm for telecentric and non-telecentric DHM systems (e.g., generalization)



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Collaborators

Dr. Jorge Garcia-Sucerquia, School of Physics, Universidad Nacional de Colombia Sede Medellin, Colombia.

Dr. Genaro Saavedra and Manuel Martinez-Corral, Department of Optics, Univ. of Valencia, Spain

Dr. Bahram Javidi, Department of Electrical and Computer Engineering, University of Connecticut, CT.

Dr. Chrysanthe Preza, Department of Electrical and Computer Engineering, The University of Memphis, TN.

Dr. Heidi Ottevaere, Faculty of Engineering, Vrije Universiteit Brussel, Belgium.

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Q&A

